

Search Notes

Application/Control No.

10/030,070

Examiner

Annan Q. Shang

Applicant(s)/Patent under
Reexamination

LETELLIER, PHILIPPE

Art Unit

2623

SEARCHED

Class	Subclass	Date	Examiner
725	34-36,39- 43,97,109- 113	10/31/2006	A.S
709	203-207	10/31/2006	A.S
709	230-231	10/31/2006	A.S

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR